

Application No.	Applicant(s)
10/717,406	ZHAN ET AL.
Examiner	Art Unit
Toan M. Le	2863

	SEARCHED				
Class	Subclass	Date	Examiner		
702	35	4/20/2005	TL		
73	861.356	4/20/2005	TL		
73	1.72	4/20/2005	TL		
703	5	4/20/2005	TL		
703	9	4/20/2005	TL		
702	47	4/20/2005	TL		
702	100	4/20/2005	TL		
700	282	4/20/2005	TL		
Above	Updated	10/7/2005	TL		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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	SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR		
Wavelet Singularity Detection	4/20/2005	TL		
Wavelet Valve	4/20/2005	TL		
Valve Wavelet Decomposition	4/20/2005	TL		
Valve Regulator Flow Wavelet	4/20/2005	TL		
Valve Defect Wavelet	4/20/2005	TL		
East- See Search History Printout IEEE Xplore	10/7/2005	TL		